Octal, 13-Bit Voltage-Output DAC with Parallel Interface

ABSOLUTE MAXIMUM RATINGS

V_{DD} to GND ....-0.3V to +6V
V_{SS} to GND...-6V to +0.3V
Digital Input Voltage to GND ....-0.3V to (V_{DD} + 0.3V)
REF_ ....(AGND_ - 0.3V) to (V_{DD} + 0.3V)
AGND_ ....(V_{SS} - 0.3V) to (V_{DD} + 0.3V)
VOUT_ ....V_{DD} to V_{SS}
Maximum Current into REF_ Pin......................................±10mA
Maximum Current into Any Other Signal Pin ....±50mA

Continuous Power Dissipation (T_A = +70°C)
  PLCC (derate 13.33mW/°C above +70°C)...................1067mW
  Plastic FP (derate 11.11mW/°C above +70°C)..............889mW
Operating Temperature Ranges
  MAX547_C_H...0°C to +70°C
  MAX547_E_H...-40°C to +85°C
Storage Temperature Range ....-65°C to +150°C
Lead Temperature (soldering, 10sec) ....+300°C

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ELECTRICAL CHARACTERISTICS

(V_{DD} = +5V, V_{SS} = -5V, REF_ = 4.096V, AGND_ = GND = 0V, R_L = 10kΩ, C_L = 50pF, T_A = T_{MIN} to T_{MAX}, unless otherwise noted. Typical values are at T_A = +25°C.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
STATIC PERFORMANCE—ANALOG SECTION						
Resolution	N			13		Bits
Relative Accuracy	INL	MAX547A		±0.5	±2	LSB
		MAX547B		±0.5	±4	
Differential Nonlinearity	DNL	Guaranteed monotonic			±1	LSB
Bipolar Zero-Code Error				±5	±20	LSB
Gain Error				±1	±8	LSB
Power-Supply Rejection Ratio	PSRR	ΔGain/ΔV_{DD} (Note 1)			±0.0025	%/%
		ΔGain/ΔV_{SS} (Note 1)			±0.0025	
Load Regulation		R_L = ∞ to 10kΩ		0.3		LSB
REFERENCE INPUT (Note 2)						
Reference Input Range	REF	(Notes 2, 3)	AGND_		V_{DD}	V
Reference Input Resistance	RREF	Each REF_ pin (Note 3)	5			kΩ
ANALOG OUTPUT						
Maximum Output Voltage				V_{DD} - 0.5		V
Minimum Output Voltage				V_{SS} + 0.5		V
DYNAMIC PERFORMANCE—ANALOG SECTION						
Voltage-Output Slew Rate				3		V/µs
Output Settling Time		To ±$\frac{1}{2}$ LSB of full scale (Note 4)		5		µs
Digital Feedthrough				5		nV-s
Digital Crosstalk				5		nV-s
DIGITAL INPUTS (V_{DD} = 5V ±5%)						
Input Voltage High	V_{IH}		2.4			V
Input Voltage Low	V_{IL}				0.8	V
Input Current	I_{IN}	V_{IN} = 0V or V_{DD}			1.0	µA
Input Capacitance	C_{IN}	(Note 5)			10	pF

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ELECTRICAL CHARACTERISTICS (continued)

(V_{DD} = +5V, V_{SS} = -5V, REF_ = 4.096V, AGND_ = GND = 0V, R_L = 10kΩ, C_L = 50pF, T_A = T_{MIN} to T_{MAX}, unless otherwise noted. Typical values are at T_A = +25°C.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
POWER SUPPLIES						
Positive Supply Range	V_{DD}	(Note 6)	4.75		5.25	V
Negative Supply Range	V_{SS}	(Note 6)	-5.25		-4.75	V
Positive Supply Current	I_{DD}	T_A = T_{MIN} to T_{MAX}		14	44	mA
Negative Supply Current	I_{SS}	T_A = T_{MIN} to T_{MAX}		11	40	mA

Note 1: PSRR is tested by changing the respective supply voltage by ±5%.
Note 2: For best performance, REF_ should be greater than AGND_ + 2V and less than V_{DD} - 0.6V. The device operates with reference inputs outside this range, but performance may degrade. For further information on the reference, see the *Reference and Analog-Ground Inputs* section in the *Detailed Description*.
Note 3: Reference input resistance is code dependent. See *Reference and Analog-Ground Inputs* section in the *Detailed Description*.
Note 4: Typical settling time with 1000pF capacitive load is 10μs.
Note 5: Guaranteed by design. Not production tested.
**Note 6:** Guaranteed by supply-rejection test.
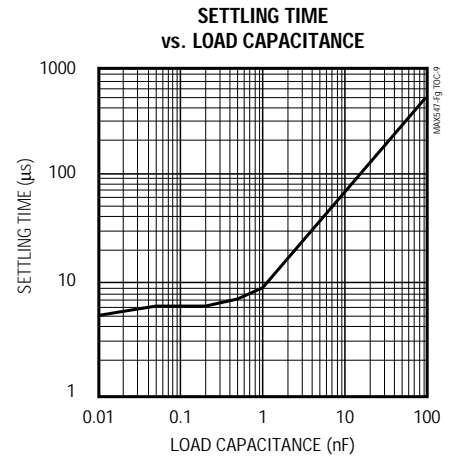
TIMING CHARACTERISTICS
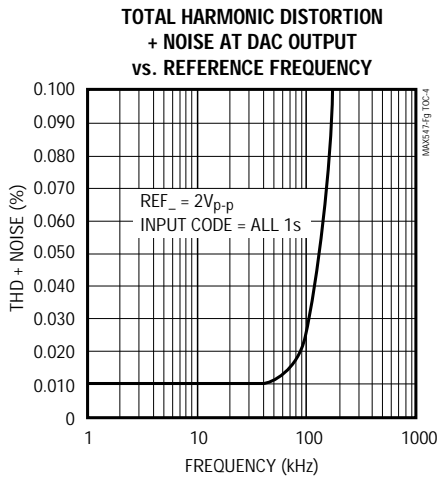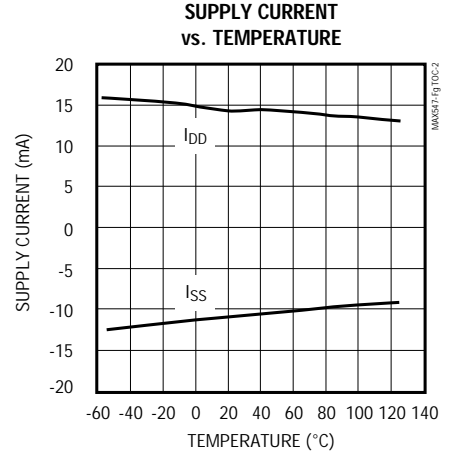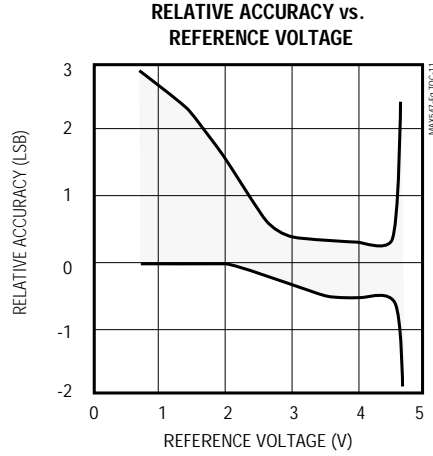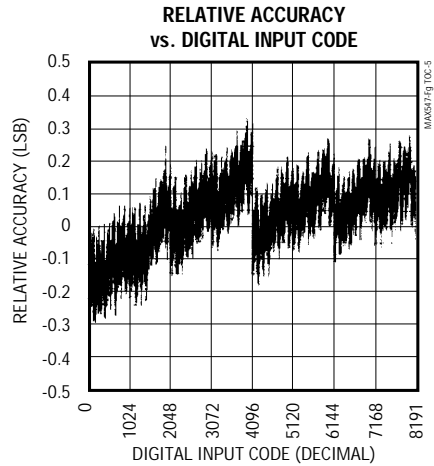
(V_{DD} = +5V, V_{SS} = -5V, REF_ = 4.096V, AGND_ = GND = 0V, T_A = T_{MIN} to T_{MAX}, unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
$\overline{CS}$ Pulse Width Low	t_1		50			ns
$\overline{WR}$ Pulse Width Low	t_2		50			ns
$\overline{LD\_}$ Pulse Width Low	t_3		50			ns
$\overline{CLR}$ Pulse Width Low	t_4		100			ns
$\overline{CS}$ Low to $\overline{WR}$ Low	t_5		0			ns
$\overline{CS}$ High to $\overline{WR}$ High	t_6		0			ns
Data Valid to $\overline{WR}$ Setup	t_7		50			ns
Data Valid to $\overline{WR}$ Hold	t_8		0			ns
Address Valid to $\overline{WR}$ Setup	t_9		10			ns
Address Valid to $\overline{WR}$ Hold	t_{10}		0			ns
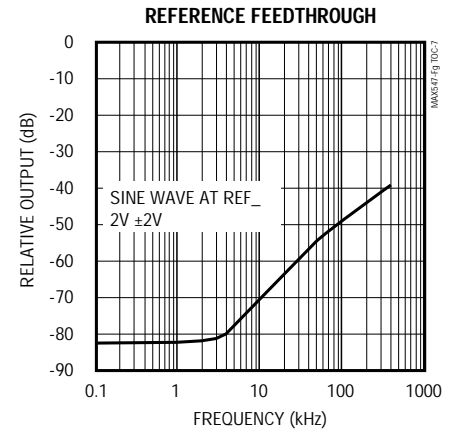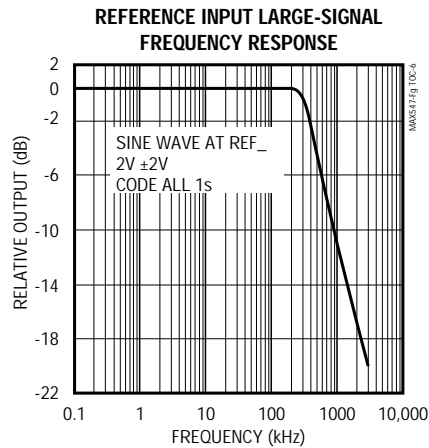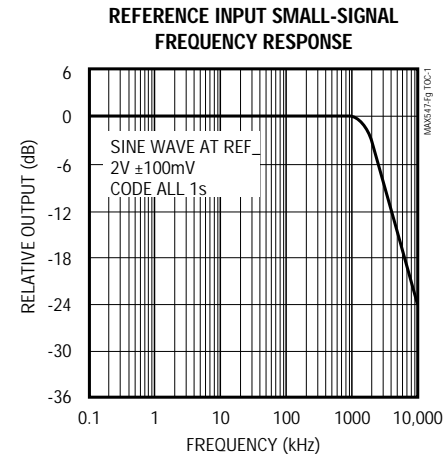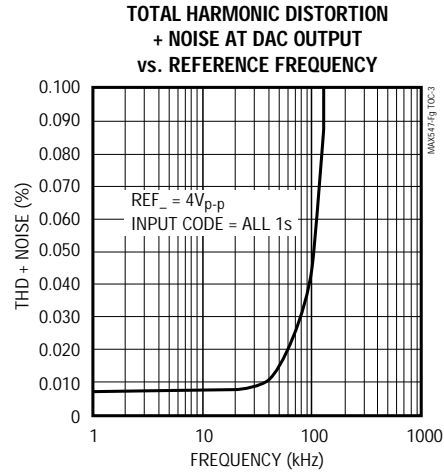
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_____*Typical Operating Characteristics*

(V$_{DD}$ = 5V, V$_{SS}$ = -5V, REF_ = 4.096V, AGND_ = GND = 0V, T$_A$ = +25°C, unless otherwise noted.)

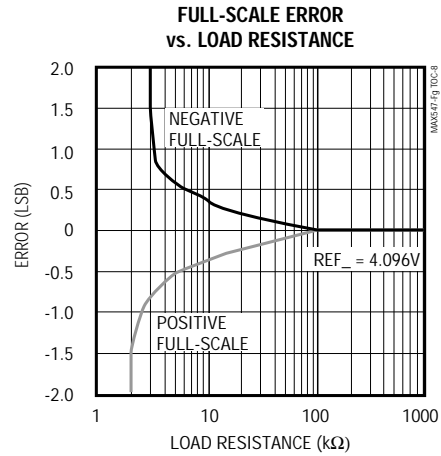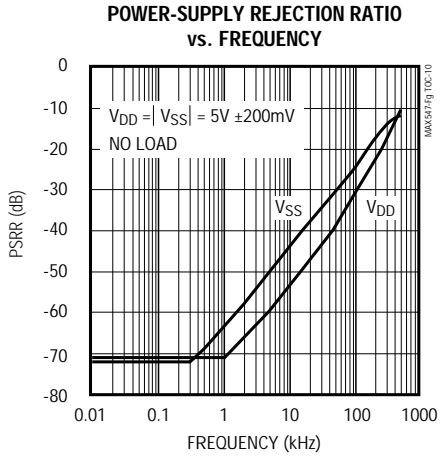**RELATIVE ACCURACY
vs. DIGITAL INPUT CODE**

**RELATIVE ACCURACY vs.
REFERENCE VOLTAGE**

**SUPPLY CURRENT
vs. TEMPERATURE**

**TOTAL HARMONIC DISTORTION
+ NOISE AT DAC OUTPUT
vs. REFERENCE FREQUENCY**

**TOTAL HARMONIC DISTORTION
+ NOISE AT DAC OUTPUT
vs. REFERENCE FREQUENCY**

**SETTLING TIME
vs. LOAD CAPACITANCE**

**REFERENCE INPUT SMALL-SIGNAL
FREQUENCY RESPONSE**

**REFERENCE INPUT LARGE-SIGNAL
FREQUENCY RESPONSE**

REFERENCE FEEDTHROUGH

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$(V_{DD} = 5V, V_{SS} = -5V, REF\_ = 4.096V, AGND\_ = GND = 0V, T_A = +25°C,$ unless otherwise noted.)

**POWER-SUPPLY REJECTION RATIO
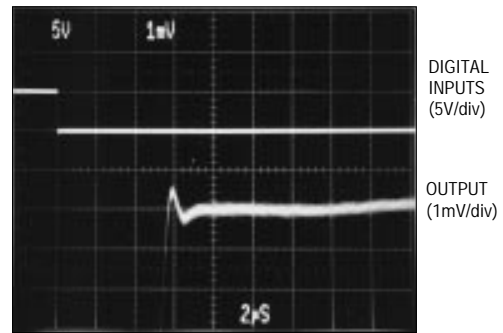vs. FREQUENCY**

**FULL-SCALE ERROR
vs. LOAD RESISTANCE**

**POSITIVE SETTLING TIME TO FULL-SCALE STEP
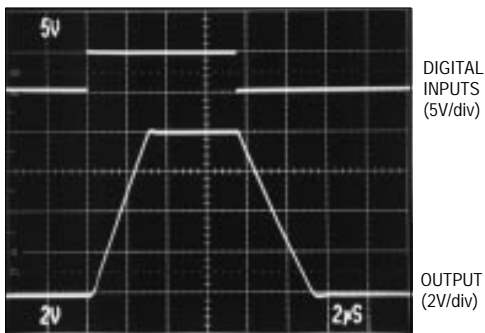(ALL BITS OFF TO ALL BITS ON)**

2μs/div
$REF\_ = 4.096V, C_L = 100pF, R_L = 5kΩ$
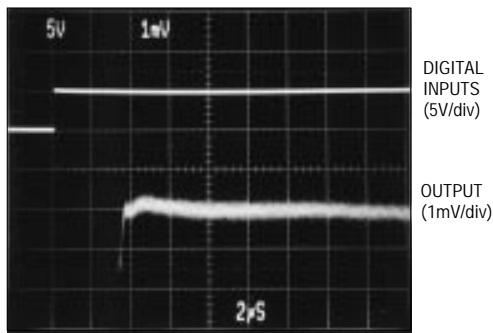
**NEGATIVE SETTLING TIME TO FULL-SCALE STEP
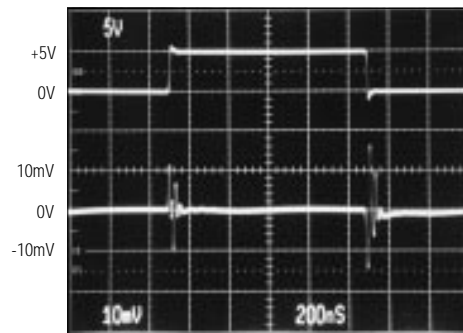(ALL BITS ON TO ALL BITS OFF)**

2μs/div
$REF\_ = 4.096V, C_L = 100pF, R_L = 5kΩ$

**DYNAMIC RESPONSE
(ALL BITS OFF, ON, OFF)**

2μs/div
$REF\_ = 4.096V, C_L = 100pF, R_L = 5kΩ$
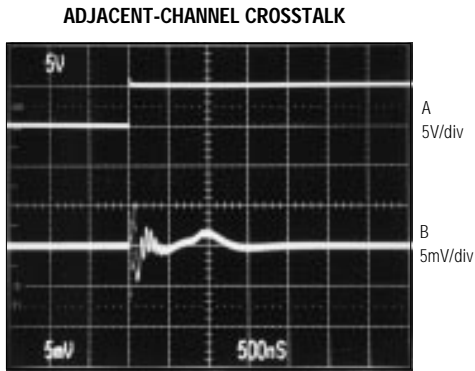
**DIGITAL FEEDTHROUGH
(GLITCH IMPULSE)**

200ns/div
TOP: DIGITAL TRANSITION ON ALL DATA BITS
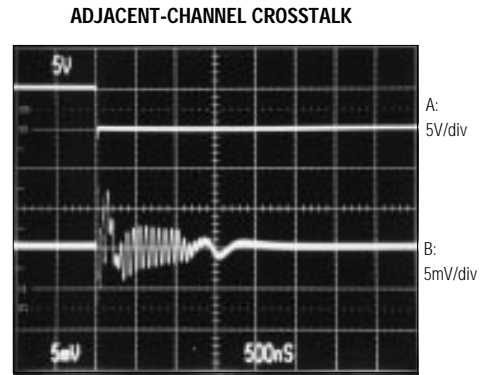BOTTOM: DAC OUTPUT WITH $\overline{WR}$ HIGH 10mV/div

_/VI/XI/VI_

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_____**Typical Operating Characteristics (continued)**

(V_{DD} = 5V, V_{SS} = -5V, REF_ = 4.096V, AGND_ = GND = 0V, T_A = +25°C, unless otherwise noted.)

ADJACENT-CHANNEL CROSSTALK

500ns/div
REF_ = 4.096V, C_L = 50pF, R_L = 10kΩ
A: DIGITAL INPUTS, DAC A, DATA BITS from ALL 0s to 0AAAhex
B: OUTPUT, DAC B

ADJACENT-CHANNEL CROSSTALK

500ns/div
REF_ = 4.096V, C_L = 50pF, R_L = 10kΩ
A: DIGITAL INPUTS, DAC A, DATA BITS from 0AAAhex to ALL 0s
B: OUTPUT, DAC B

_____**Pin Description**

PIN		NAME	FUNCTION
PLCC	FLAT PACK		
1	39	$\overline{CLR}$	Clear Input (active low). Driving this asynchronous input low sets the content of all latches to 1000hex. All DAC outputs are reset to AGND_.
2	40	AGNDCD	Analog Ground for DAC C and DAC D
3	41	REFCD	Reference Voltage Input for DAC C and DAC D. Bypass to AGNDCD with a 0.1μF to 1μF capacitor.
4, 42	42, 36	V_{SS}	Negative Power Supply, -5V (2 pins). Connect both pins to the supply voltage. Bypass each pin to the system analog ground with a 0.1μF to 1μF capacitor.
5	43	VOUTD	DAC D Output Voltage
6	44	VOUTC	DAC C Output Voltage
7	1	VOUTB	DAC B Output Voltage
8	2	VOUTA	DAC A Output Voltage
9, 37	3, 31	V_{DD}	Positive Power Supply, 5V (2 pins). Connect both pins to the supply voltage. Bypass each pin to the system analog ground with a 0.1μF to 1μF capacitor.
10	4	REFAB	Reference Voltage Input for DAC A and DAC B. Bypass to AGNDAB with a 0.1μF to 1μF capacitor.
11	5	AGNDAB	Analog Ground for DAC A and DAC B
12	6	$\overline{LDAB}$	Load Input (active low). Driving this asynchronous input low transfers the contents of input latches A and B to the respective DAC latches.
13	7	$\overline{LDCD}$	Load Input (active low). Driving this asynchronous input low transfers the contents of input latches C and D to the respective DAC latches.
14	8	$\overline{CS}$	Chip Select (active low)
15	9	$\overline{WR}$	Write Input (active low). $\overline{WR}$, along with $\overline{CS}$, loads data into the DAC input latch selected by A0–A2.

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PIN		NAME	FUNCTION
PLCC	FLAT PACK		
16	10	A2	Address Bit 2
17	11	A1	Address Bit 1
18	12	A0	Address Bit 0
19–31	13–25	D12–D0	Data Bits 12–0
32	26	$\overline{\text{LDEF}}$	Load Input (active low). Driving this asynchronous input low transfers the contents of input latches E and F to the respective DAC latches.
33	27	$\overline{\text{LDGH}}$	Load Input (active low). Driving this asynchronous input low transfers the contents of input latches G and H to the respective DAC latches.
34	28	GND	Digital Ground
35	29	AGNDGH	Analog Ground for DAC G and DAC H
36	30	REFGH	Reference Voltage Input for DAC G and DAC H. Bypass to AGNDGH with a 0.1µF to 1µF capacitor.
38	32	VOUTH	DAC H Output Voltage
39	33	VOUTG	DAC G Output Voltage
40	34	VOUTF	DAC F Output Voltage
41	35	VOUTE	DAC E Output Voltage
43	37	REFEF	Reference Voltage Input for DAC E and DAC F. Bypass to AGNDEF with a 0.1µF to 1µF capaci-
44	38	AGNDEF	Analog Ground for DAC E and DAC F

_____Detailed Description

Analog Section

The MAX547 contains eight 13-bit, voltage-output DACs. These DACs are "inverted" R-2R ladder networks that convert 13-bit digital inputs into equivalent analog output voltages, in proportion to the applied reference voltages. The MAX547 has one reference input (REF_) and one analog-ground input (AGND_) for each pair of DACs. The four REF_ inputs allow different full-scale output voltages for each DAC pair, and the four AGND_ inputs allow different offset voltages for each DAC pair.

The DAC ladder outputs are buffered with op amps that operate with a gain of two. The inverting node of the amplifier is connected to the respective reference input, resulting in bipolar output voltages from -REF_ to 4095/4096 REF_. Figure 1 shows the simplified DAC circuit.
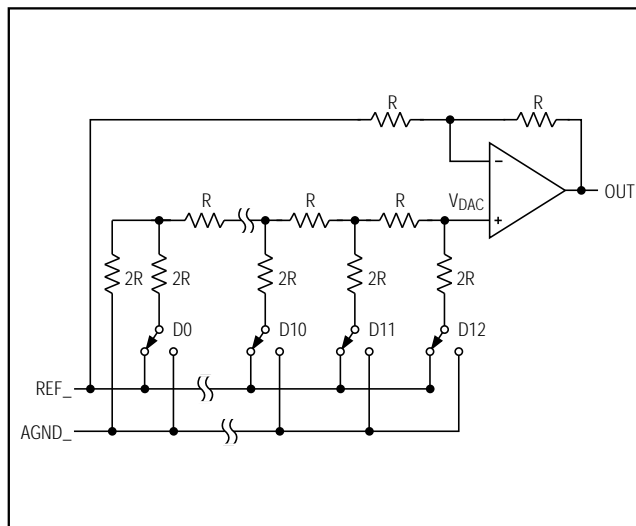

Figure 1. DAC Simplified Circuit Diagram

Reference and Analog-Ground Inputs

The REF_ inputs can range between AGND_ and V_{DD}. However, the DAC outputs will operate to V_{DD} - 0.6V and V_{SS} + 0.6V, due to the output amplifiers' voltage-swing limitations. The AGND_ inputs can be offset by any voltage within the supply rails. The offset-voltage potential must be lower than the reference-voltage potential. For more information, refer to the *Digital Code* and *Analog Output Voltage* section in the *Applications Information.*

The input impedance of the REF_ inputs is code dependent. It is at its lowest value (5kΩ min) when the input code of the referring DAC pair is 0 1010 1010 1010 (0AAAhex). Its maximum value, typically 50kΩ, occurs when the code is 0000hex. When all reference inputs are driven from the same source, the minimum load impedance is 1.25kΩ. Since the input impedance at REF_ is code dependent, load regulation of the reference used is important. For more information, see *Reference Selection* in the *Applications Information* section.

The input capacitance at REF_ is also code dependent, and typically varies from 125pF to 300pF. Its minimum value occurs when the code of the referring DAC pair is set to all 0s. It is at its maximum value with all 1s on both DACs.

Output Buffer Amplifiers

The MAX547's voltage outputs are internally buffered by precision gain-of-two amplifiers with a typical slew rate of 3V/µs. With a full-scale transition at its output, the typical settling time to $\pm^{1}/_{2}$LSB is 5µs when loaded with 10kΩ in parallel with 50pF, or 6µs when loaded with 10kΩ in parallel with 100pF.

Digital Inputs and Interface Logic

All digital inputs are compatible with both TTL and CMOS logic. The MAX547 interfaces with microprocessors using a data bus at least 13 bits wide. The interface is double buffered, allowing simultaneous update of all DACs. There are two latches for each DAC (see *Functional Diagram*): an input latch that receives data from the data bus, and a DAC latch that receives data from the input latch. Address lines A0, A1, and A2 select which DAC's input latch receives data from the data bus, as shown in Table 1. Transfer data from the input latches to the DAC latches by asserting the asynchronous $\overline{LD\_}$ signal. Each DAC's analog output reflects the data held in its DAC latch. All control inputs are level triggered.

Data can be latched or transferred directly to the DAC. $\overline{CS}$ and $\overline{WR}$ control the input latch and $\overline{LD\_}$ transfers information from the input latch to the DAC latch. The input latch is transparent when $\overline{CS}$ and $\overline{WR}$ are low, and

Table 1. MAX547 DAC Addressing

A2	A1	A0	FUNCTION
0	0	0	DAC A input latch
0	0	1	DAC B input latch
0	1	0	DAC C input latch
0	1	1	DAC D input latch
1	0	0	DAC E input latch
1	0	1	DAC F input latch
1	1	0	DAC G input latch
1	1	1	DAC H input latch

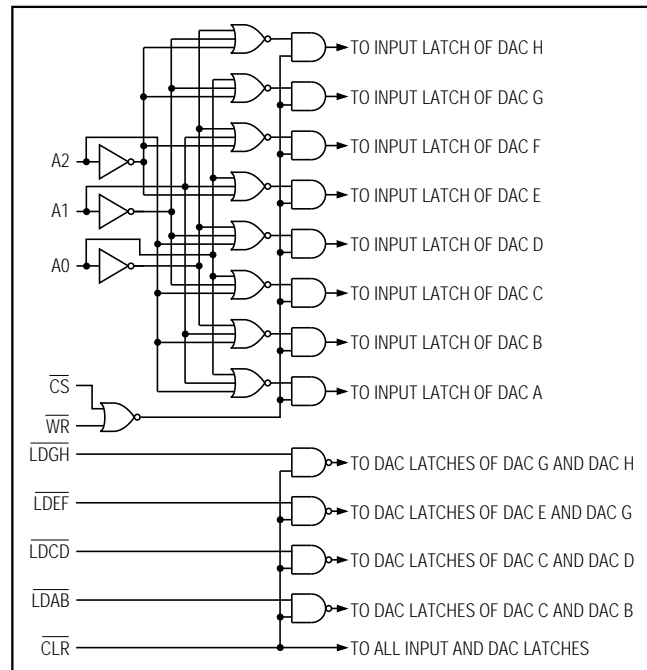*Figure 2. Input Control Logic*

the DAC latch is transparent when $\overline{LD\_}$ is low. The address lines (A0, A1, A2) must be valid throughout the time $\overline{CS}$ and $\overline{WR}$ are low (Figure 3). Otherwise, the data can be inadvertently written to the wrong DAC. Data is latched within the input latch when either $\overline{CS}$ or $\overline{WR}$ is high. Taking $\overline{LD\_}$ high latches data into the DAC latches.

If $\overline{LD\_}$ is brought low when $\overline{WR}$ and $\overline{CS}$ are low, it must be held low for t_3 or longer after $\overline{WR}$ and $\overline{CS}$ are high (Figure 3).

Pulling the asynchronous $\overline{CLR}$ input low sets all DAC outputs to a nominal 0V, regardless of the state of $\overline{CS}$, $\overline{WR}$, and $\overline{LD\_}$. Taking $\overline{CLR}$ high latches 1000hex into all input latches and DAC latches.

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Table 2. Interface Truth Table

$\overline{CLR}$	$\overline{LD\_}$	$\overline{WR}$	$\overline{CS}$	FUNCTION
1	0	0	0	Both latches transparent
1	1	1	X	Both latches latched
1	1	X	1	Both latches latched
1	X	0	0	Input latch transparent
1	X	1	X	Input latch latched
1	X	X	1	Input latch latched
1	0	X	X	DAC latch transparent
0	X	X	X	All input and DAC latches at 1000hex, outputs at AGND_

NOTES:

1. ALL INPUT RISE AND FALL TIMES MEASURED FROM 10% TO 90% OF +5V. $t_r = t_f = 5ns$.

2. MEASUREMENT REFERENCE LEVEL IS $(V_{INH} + V_{INL})/2$.

3. IF $\overline{LD\_}$ IS ACTIVATED WHILE $\overline{WR}$ IS LOW THEN $\overline{LD\_}$ MUST STAY LOW FOR t_3 OR LONGER AFTER $\overline{WR}$ GOES HIGH.
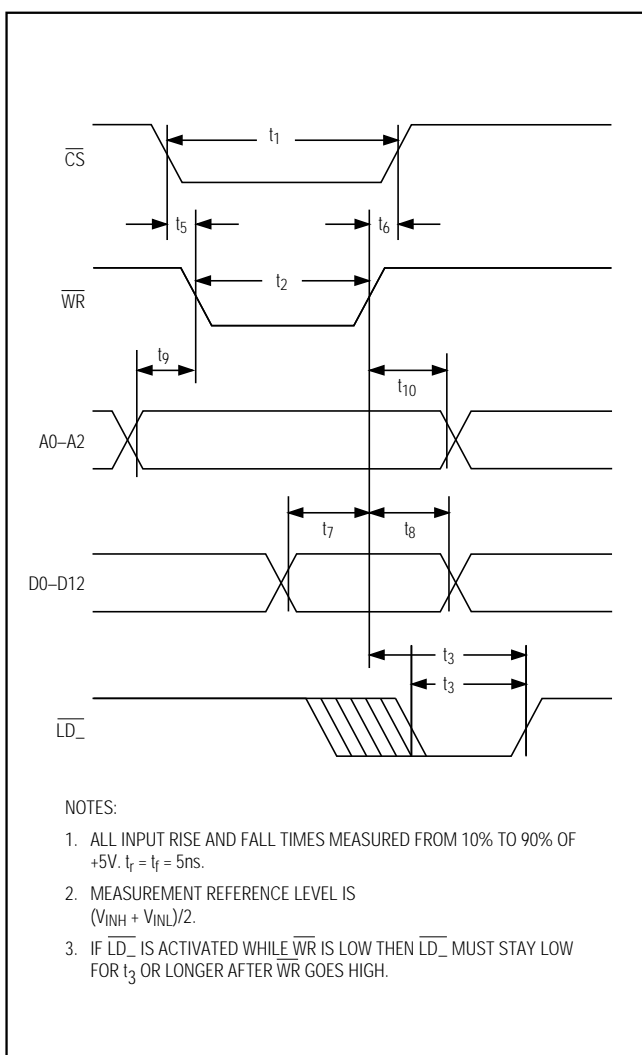
Figure 3. Write-Cycle Timing

_____Applications Information

Multiplying Operation

The MAX547 can be used for multiplying applications. Its reference accepts both DC and AC signals. The voltage at each REF_ input sets the full-scale output voltage for its respective DACs. Since the reference inputs accept only positive voltages, multiplying operation is limited to two quadrants. Do not bypass the reference inputs when applying AC signals to them. Refer to the graphs in the *Typical Operating Characteristics* for dynamic performance of the DACs and output buffers.

Digital Code and Analog Output Voltage

The MAX547 uses offset binary coding. A 13-bit two-complement code can be converted to a 13-bit offset binary code by adding $2^{12} = 4096$.

Bipolar Output Voltage Range (AGND_ = 0V)

For symmetrical bipolar operation, tie AGND_ to the system ground. Table 3 shows the relationship between digital code and output voltage. The following paragraphs give a detailed explanation of this mode.

The DAC ladder output voltage (V_{DAC}) is multiplied by 2 and level shifted by the reference voltage, which is internally connected to the output amplifiers (Figure 1). Since the feedback resistors are the same size, the amplifier's output voltage is 2 times the voltage at its noninverting input, minus the reference voltage.

$$VOUT = 2(V_{DAC}) - REF\_$$

where VDAC is the voltage at the amplifier's noninverting input (DAC ladder output voltage), and REF_ is the voltage applied to the reference input of the DAC.

With AGND_ connected to the system ground, the DAC ladder output voltage is:

$$V_{DAC} = \frac{D}{2^n}(REF\_) = \frac{D}{2^{13}}(REF\_)$$

where D is the numeric value of the DAC's binary input code and n is the DAC's resolution (13 bits). Replace V_{DAC} in the equation and calculate the output voltage.

$$VOUT\_ = 2\left(\frac{D}{2^{13}}\right)(REF\_) - REF\_$$

$$= REF\_\left(\frac{D}{2^{12}} - 1\right) = REF\_\left(\frac{D}{4096} - 1\right)$$

D ranges from 0 (2^0) to 8191 (2^{13} - 1).

$$1LSB = REF\_\left(\frac{1}{4096}\right)$$

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Table 3. MAX547 Bipolar Code Table
(AGND_ = 0V)

INPUT	OUTPUT
1 1111 1111 1111	$+REF_- \left(\dfrac{4095}{4096} \right)$
1 0000 0000 0001	$+REF_- \left(\dfrac{1}{4096} \right)$
1 0000 0000 0000	0V
0 1111 1111 1111	$-REF_- \left(\dfrac{1}{4096} \right)$
0 0000 0000 0001	$-REF_- \left(\dfrac{4095}{4096} \right)$
0 0000 0000 0000	$-REF_-$

Table 4. MAX547 Positive Unipolar Code Table
(AGND_ = $\dfrac{REF_-}{2}$)

INPUT	OUTPUT
1 1111 1111 1111	$+REF_- \left(\dfrac{8191}{8192} \right)$
1 0000 0000 0000	$+REF_-/2$
0 0000 0000 0000	0V

Customizing the Output Voltage Range

The AGND_ inputs can be offset by any voltage within the supply rails if the voltage at the referring REF_ input is higher than the voltage at the AGND_ input. Select the reference voltage and the voltage at AGND_ so the resulting output voltages do not come within ±0.6V of the supply rails. Figure 4's circuit shows one way to add positive offset to AGND_; make sure that the op amp used has sufficient current-sink capability to take up the remaining AGND_ current:

$$I_{AGND_-} = \left(\frac{REF_- - AGND_-}{5k\Omega} \right)$$

Another way is to digitally offset AGND_ by connecting the output of one DAC to one or more AGND_ inputs. Do not connect a DAC output to its own AGND_ input.

Table 5 summarizes the relationship between the reference and AGND_ potentials and the output voltage in the different modes of operation.

Power-Supply Sequencing

The sequence in which the supply voltages come up is not critical. However, we recommend that on power-up, V_{SS} comes up first, V_{DD} next, followed by the reference voltages. If you use other sequences, limit the current into any reference pin to 10mA. Also, make sure that V_{SS} is never more than 300mV above ground. If there is a risk that this can occur at power-up, connect a Schottky diode between V_{SS} and GND, as shown in Figure 5. We recommend that you not power up the logic input pins before establishing the supply voltages. If this is not possible and the digital lines can drive more than 10mA, you should place current-limiting resistors (e.g., 470Ω) in series with the logic pins.

Reference Selection

If you want a ±2.5V full-scale output voltage swing, you can use the MAX873 reference. It operates from a single 5V supply and is specified to drive up to 10mA. Therefore, it can drive all four reference inputs simultaneously. Because the maximum load impedance can vary from 1.25kΩ to 12.5kΩ (four reference inputs in parallel), the reference load current ranges from 2mA to 0.2mA (1.8mA maximum load step). The MAX873's
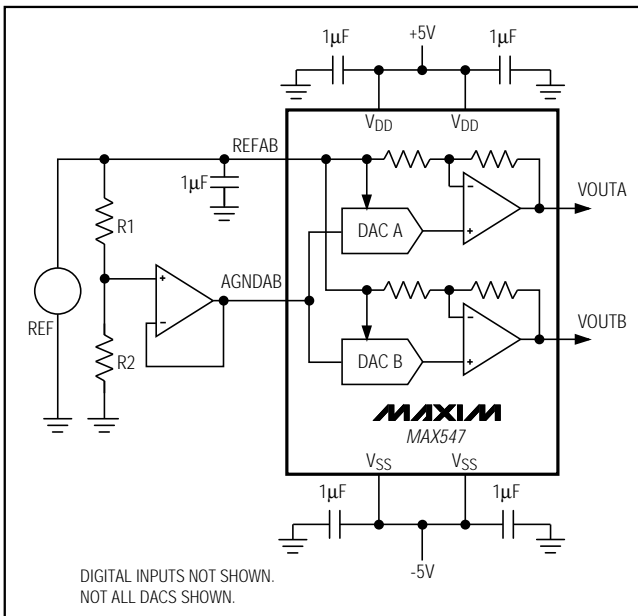

Figure 4. Offsetting AGND_

Positive Unipolar Output Voltage Range
(AGND_ = REF_/2)

For positive unipolar output operation, set AGND_ to (REF_/2). For example, if you use Figure 4's circuit with, a 4.096V reference and offset AGND_ by 2.048V with matched resistors (R1 = R2) and an op amp, it results in a 0V to 4.0955V (nominal) unipolar output voltage, where 1LSB = 500µV. In general, the maximum current flowing out of any AGND_ pin is given by:

$$I_{AGND_-} = \left(\frac{REF_- - AGND_-}{5k\Omega} \right)$$

/M/IXI/M

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Table 5. Reference, AGND_ and Output Relationships

PARAMETER	BIPOLAR OPERATION (AGND_ = 0V)	POSITIVE UNIPOLAR OPERATION (AGND_ = REF_/2)	CUSTOM OPERATION
Bipolar Zero Level, or Unipolar Mid-scale, (Code = 1000000000000)	AGND_ (=0V)	$AGND\_ \left(= \dfrac{REF\_}{2} \right)$	AGND_
Differential Reference Voltage (V_{DR})	REF_	REF_/2	REF_ - AGND_
Negative Full-scale Output (Code = All 0s)	-REF_	0V	AGND_ - V_{DR}
Positive Full-Scale Output (Code = All 1s)	$\left(\dfrac{4095}{4096} \right)\left(REF\_ \right)$	$\left(\dfrac{8191}{8192} \right)\left(REF\_ \right)$	$AGND\_ + \left(\dfrac{4095}{4096} \right)\left(V_{DR} \right)$
LSB Weight	$\dfrac{REF\_}{4096}$	$\left(\dfrac{REF\_}{8192} \right)$	$\dfrac{V_{DR}}{4096}$
VOUT_ as a Function of Digital Code (D, 0 to 8191)	$\left(\dfrac{D}{4096} - 1 \right)\left(REF\_ \right)$	$\left(\dfrac{D}{8192} \right)\left(REF\_ \right)$	$AGND\_ + \left(\dfrac{D}{4096} - 1 \right)\left(V_{DR} \right)$

load regulation is specified to 20ppm/mA max over temperature, resulting in a maximum error of 36ppm (90µV). This corresponds to a maximum error caused by reference load regulation of only 0.147LSB [0.147LSB = 90µV/(5V/8192)LSB] over temperature.

If you want a ±4.096V full-scale output swing (1LSB = 1mV), you can use the calibrated, low-drift, low-dropout MAX676. Operating from a 5V supply, it is fully specified to drive two REF_ inputs with less than 60.4µV error (0.0604LSB) over temperature, caused by the maximum load step.

Reference Buffering

Another way to obtain high accuracy is to buffer a reference with an op amp. When driving all reference inputs simultaneously, keep the closed-loop output impedance of the op amp below 0.03Ω to ensure an error of less than 0.1LSB. The op amp must also drive the capacitive load (typically 500pF to 1200pF).

Each reference input can also be buffered separately by using the circuit in Figure 6. A reference load step caused by a digital transition only affects the DAC pair where the code transition occurs. It also allows the use of references with little drive capability. Keep the closed-loop output impedance of each op amp below 0.12Ω, to ensure an error of less than 0.1LSB. Figure 6 shows the op amp's inverting input directly connected to the MAX547's reference terminal. This eliminates the
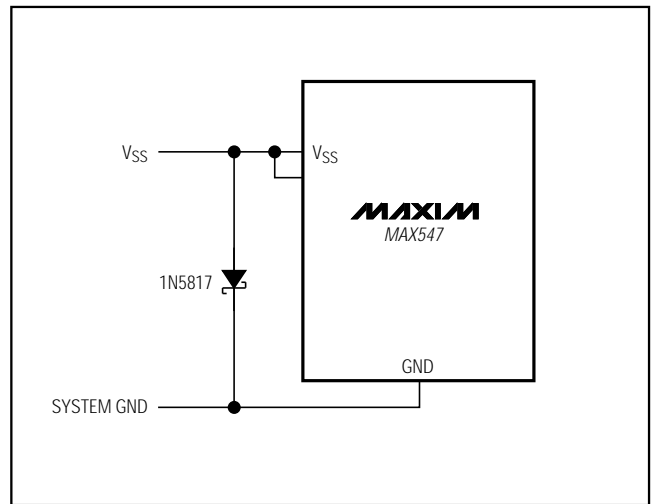

Figure 5. Optional Schottky Diode between V_{SS} and GND

influence of board lead resistance by sensing the voltage with a low-current path sense line directly at the reference input.

Adding feedback resistors to individual reference buffer amplifiers enables different reference voltages to be generated from a single reference.

MAX547

Figure 6. Reference Buffering

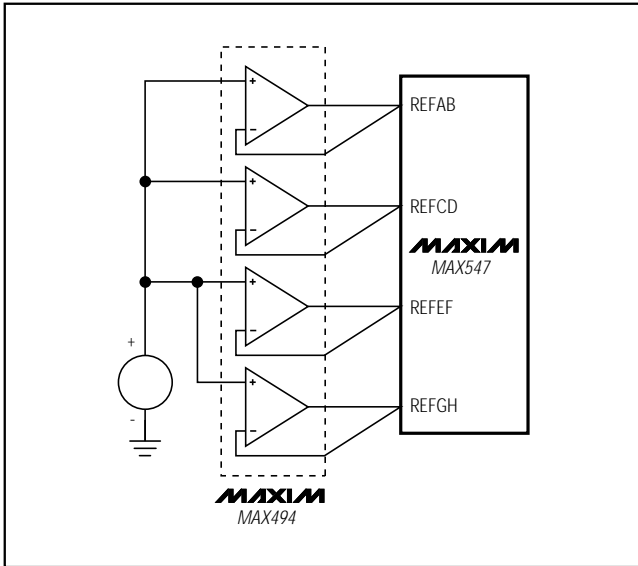| PART	TEMP. RANGE	PIN-PACKAGE	INL (LSBs)
MAX547AEQH	-40°C to +85°C	44 PLCC	±2
MAX547BEQH	-40°C to +85°C	44 PLCC	±4
MAX547AEMH	-40°C to +85°C	44 Plastic FP	±2
MAX547BEMH	-40°C to +85°C	44 Plastic FP	±4

Power-Supply Bypassing and Ground Management

For optimum performance, use a multilayer PC board with an unbroken analog ground. For normal operation, when all AGND_ pins are at the same potential, connect the four AGND_ pins directly to the ground plane or connect them together in a "star" configuration. The center of this star point is a good location to connect the digital system ground with the analog ground.

If you are using a single common reference voltage, you can connect the reference inputs together using a "star" configuration. If you are using DC reference voltages, bypass each reference input with a 0.1µF to 1µF capacitor to AGND_.

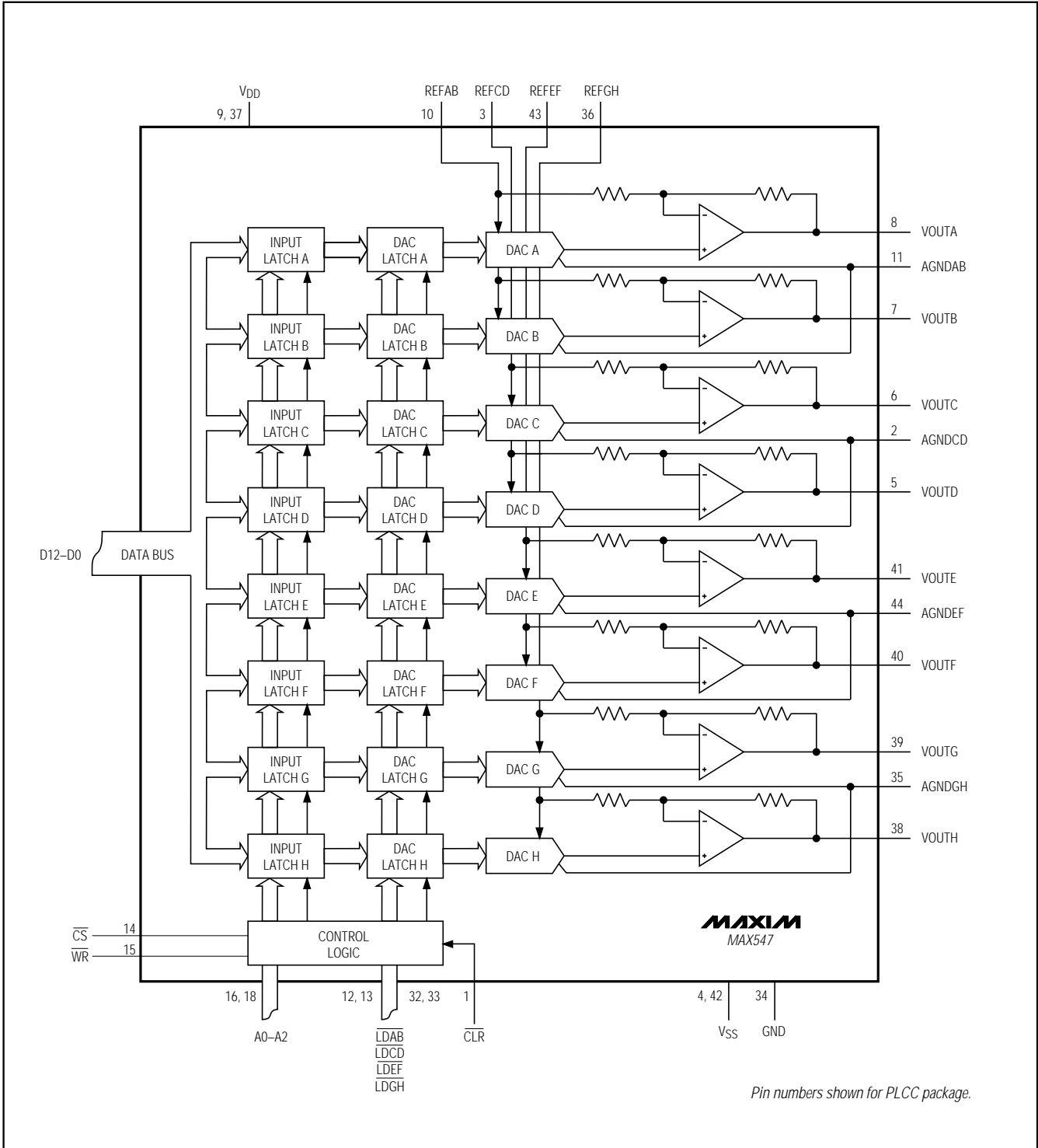*MAXIM*

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_____***Functional Diagram***

Pin numbers shown for PLCC package.

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_____**Chip Topography**

0.242"
(6.147mm)

0.199"
(5.055mm)
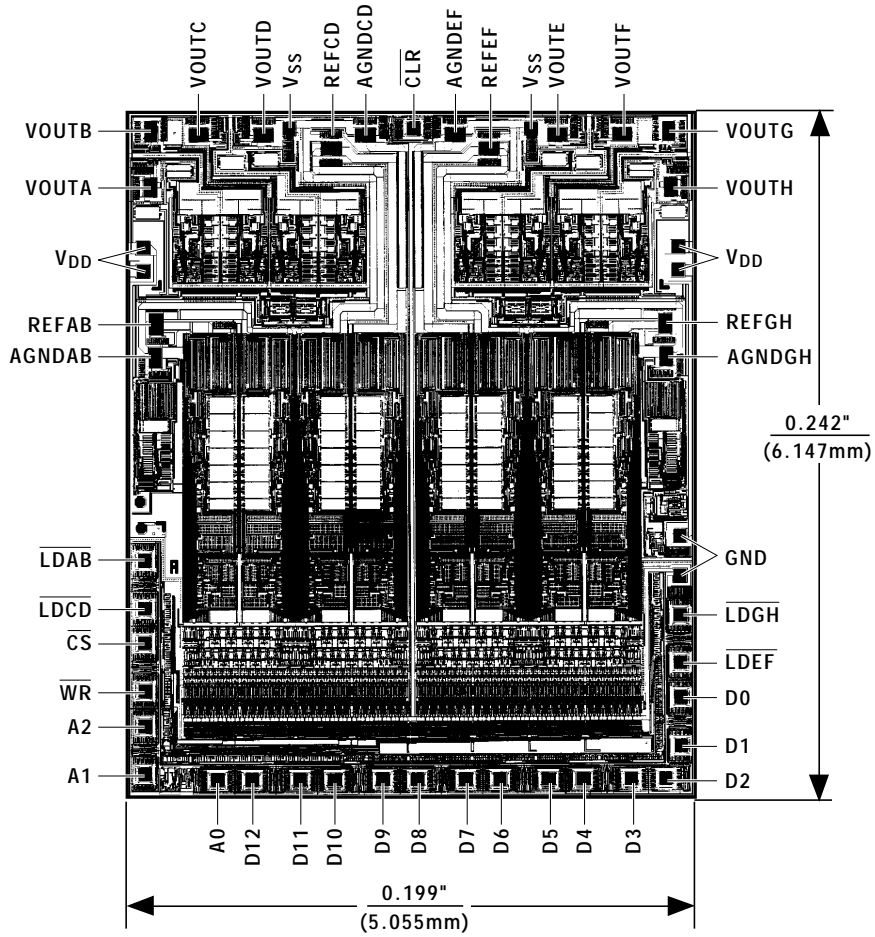
TRANSISTOR COUNT: 8987

SUBSTRATE CONNECTED TO V$_{DD}$

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Package Information

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.165	0.180	4.19	4.57
A1	0.100	0.110	2.54	2.79
A2	0.145	0.156	3.68	3.96
A3	0.020	–	0.51	–
B	0.013	0.021	0.33	0.53
B1	0.026	0.032	0.66	0.81
C	0.009	0.011	0.23	0.28
D	0.685	0.695	17.40	17.65
D1	0.650	0.655	16.51	16.64
D2	0.590	0.630	14.99	16.00
D3	0.500 REF		12.70 REF	
e	0.050 REF		1.27 REF	

21-350A

44-PIN PLASTIC LEADED CHIP CARRIER PACKAGE

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MAX547AEMH+ MAX547AEMH+T MAX547AEQH+D MAX547AEQH+TD MAX547BCMH+ MAX547BCMH+T
MAX547BCMH+TD MAX547BCQH+TD MAX547BEMH+ MAX547BEMH+T MAX547BEQH+D MAX547BEQH+TD
MAX547AEMH MAX547AEMH-T